

**Search Notes**

Application/Control No.

10/711,262

Examiner

Derek S. Chapel

Applicant(s)/Patent under  
Reexamination

OKUBO ET AL.

Art Unit

2872

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference Search (see attached)		2/24/2006	DSC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Class/Subclass search: 359/1,4,5,6,7,490,492,494,495,497,50 0,577,652,653,654 (text only, see attached)	2/13/2006	DSC
Class/Subclass search: 430/1,2; 252/582,585; 427/162,163.1 (text only, see attached)	2/13/2006	DSC
NPL search (INSPEC, see attached)	2/14/2006	DSC
Consulted with Arnel Lavarias about the claims and search	2/13/2006	DSC
PLUS search	2/13/2006	DSC